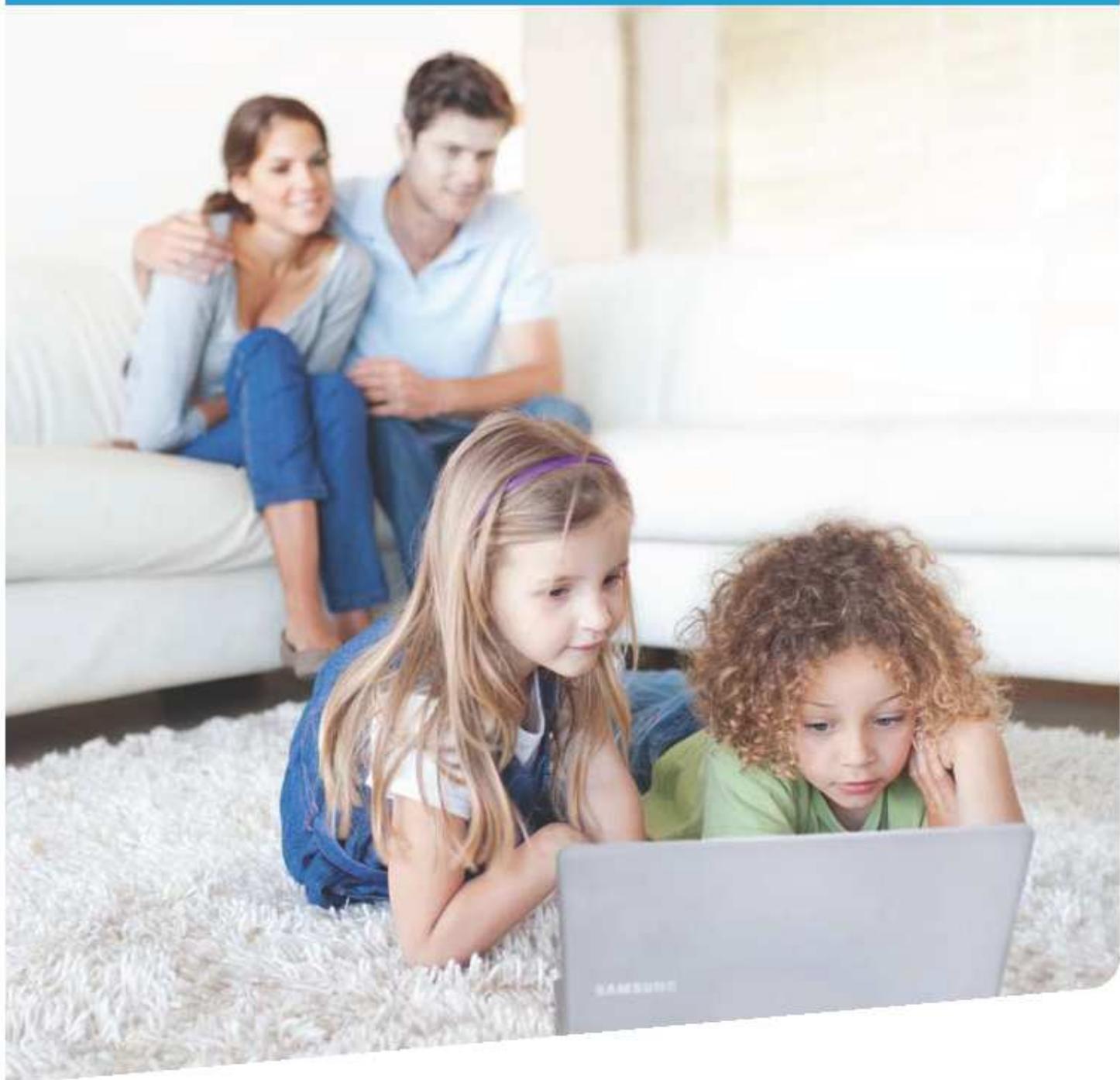


Samsung Electronics  
LED Components

# IES LM-80 Test Results



# IES LM-80 Test Results

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# IES LM-80 Test Results

## LM231A

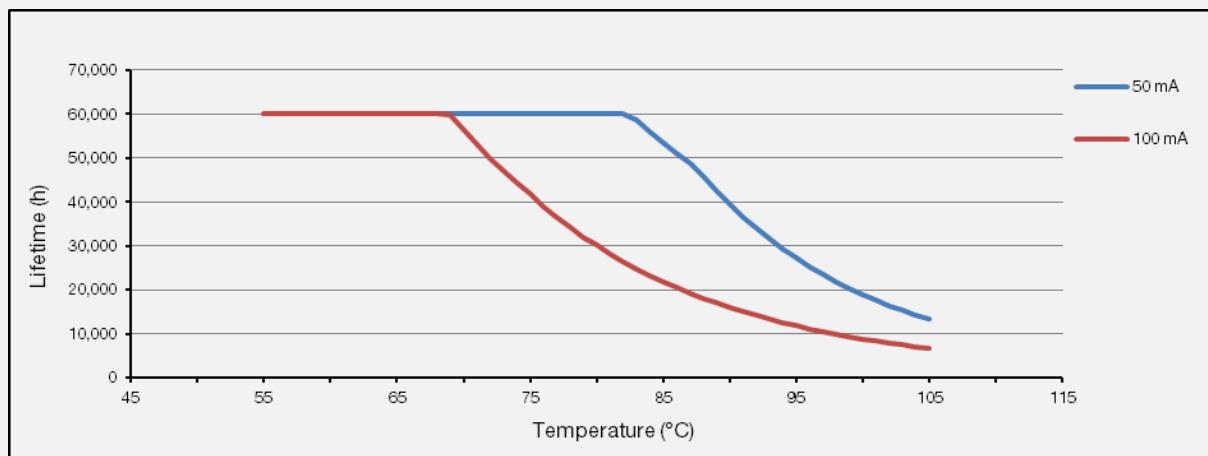
- Report date: 2012.03.26
- Applicable order codes: SPMWHT221\*\*\*\*\*

### Test Summary

- Sample size: 26 pcs
- Number of failures: 0 pcs

Drive Current (mA)	Temperature T <sub>s</sub> (°C)	Test Duration (h)	Test Result Lumen Maintenance	Reported IES TM-21-11 Lifetime (h)		
				L <sub>70</sub>	L <sub>80</sub>	L <sub>90</sub>
50	55	10,000	98.7 %	> 60,000	> 60,000	> 60,000
	85		94.2 %	= 54,000	= 34,000	= 17,000
	105		78.7 %	= 14,000	= 10,000	= 6,000
100	55	10,000	98.2 %	> 60,000	> 60,000	= 50,000
	85		85.6 %	= 22,000	= 14,000	= 7,000
	105		66.5 %	= 9,000	= 6,000	= 4,000

### L<sub>70</sub> Temperature Interpolation Graph



# IES LM-80 Test Results

## LM231B

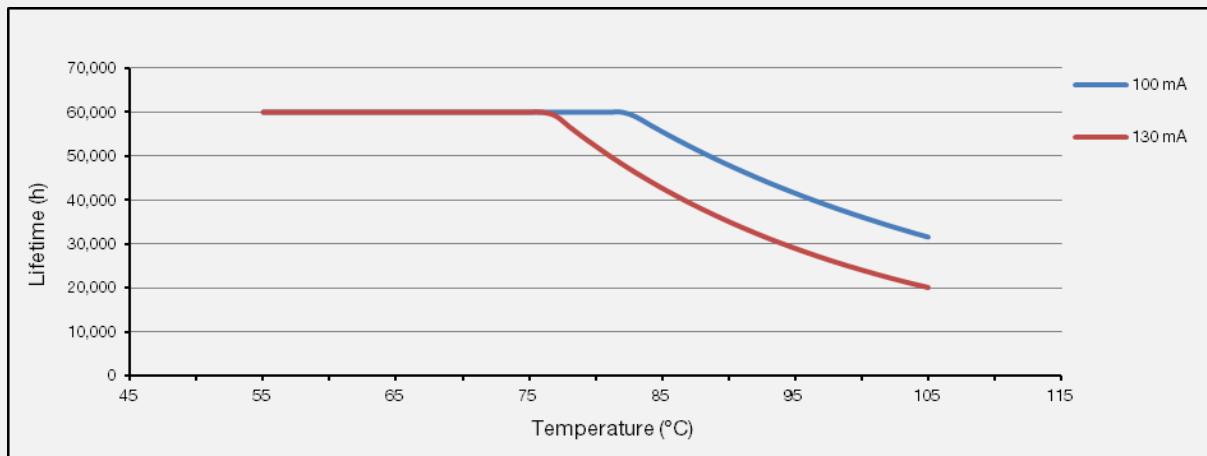
- Report date: 2014.07.25
- Applicable order codes: SPMWHT223\*\*\*\*\*

### Test Summary

- Sample size: 28 pcs
- Number of failures: 0 pcs

Drive Current (mA)	Temperature $T_s$ (°C)	Test Duration (h)	Test Result Lumen Maintenance	Reported IES TM-21-11 Lifetime (h)		
				$L_{70}$	$L_{80}$	$L_{90}$
100	55	10,000	98.2 %	> 60,000	> 60,000	= 48,000
	85		95.1 %	= 56,000	= 36,000	= 18,000
	105		91.3 %	= 34,000	= 22,000	= 11,000
130	55	10,000	98.5 %	> 60,000	> 60,000	= 46,000
	85		93.6 %	= 42,000	= 28,000	= 15,000
	105		87.6 %	= 21,000	= 14,000	= 8,000

### $L_{70}$ Temperature Interpolation Graph



# IES LM-80 Test Results

## LM362A

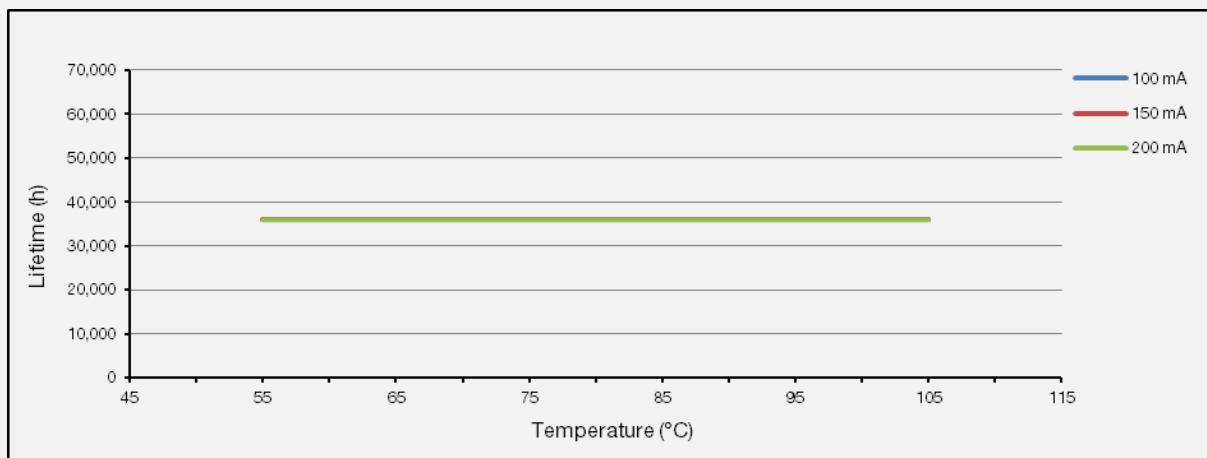
- Report date: 2013.05.08
- Applicable order codes: SPMWHT352A\*\*\*\*\*

### Test Summary

- Sample size: 25 pcs
- Number of failures: 0 pcs

Drive Current (mA)	Temperature T <sub>s</sub> (°C)	Test Duration (h)	Test Result Lumen Maintenance	Reported IES TM-21-11 Lifetime (h)		
				L <sub>70</sub>	L <sub>80</sub>	L <sub>90</sub>
100	55	6,000	99.0 %	> 36,000	> 36,000	> 36,000
	85		97.4 %	> 36,000	> 36,000	= 19,000
	105		95.5 %	> 36,000	= 28,000	= 14,000
150	55	6,000	98.5 %	> 36,000	> 36,000	> 36,000
	85		97.0 %	> 36,000	> 36,000	= 18,000
	105		95.2 %	> 36,000	= 28,000	= 13,000
200	55	6,000	97.5 %	> 36,000	> 36,000	= 28,000
	85		96.6 %	> 36,000	> 36,000	= 20,000
	105		94.0 %	= 36,000	= 22,000	= 11,000

### L<sub>70</sub> Temperature Interpolation Graph



# IES LM-80 Test Results

## LM561B

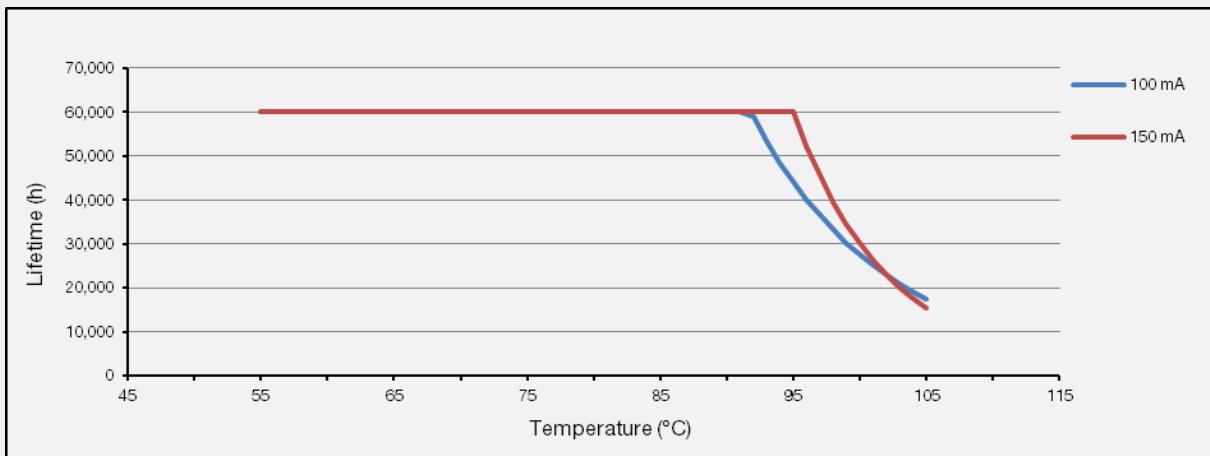
- Report date: 2014.04.29
- Applicable order codes: SPMWHT541M\*\*\*\*\*

### Test Summary

- Sample size: 30 pcs
- Number of failures: 0 pcs

Drive Current (mA)	Temperature $T_s$ (°C)	Test Duration (h)	Test Result Lumen Maintenance	Reported IES TM-21-11 Lifetime (h)		
				$L_{70}$	$L_{80}$	$L_{90}$
100	55	10,000	97.4 %	> 60,000	> 60,000	> 60,000
	85		96.2 %	> 60,000	> 60,000	= 29,000
	105		86.7 %	= 19,000	= 13,000	= 8,000
150	55	10,000	96.5 %	> 60,000	= 54,000	= 26,000
	85		96.7 %	> 60,000	> 60,000	= 55,000
	105		85.2 %	= 18,000	= 12,000	= 8,000

### $L_{70}$ Temperature Interpolation Graph



# IES LM-80 Test Results

## LH351A

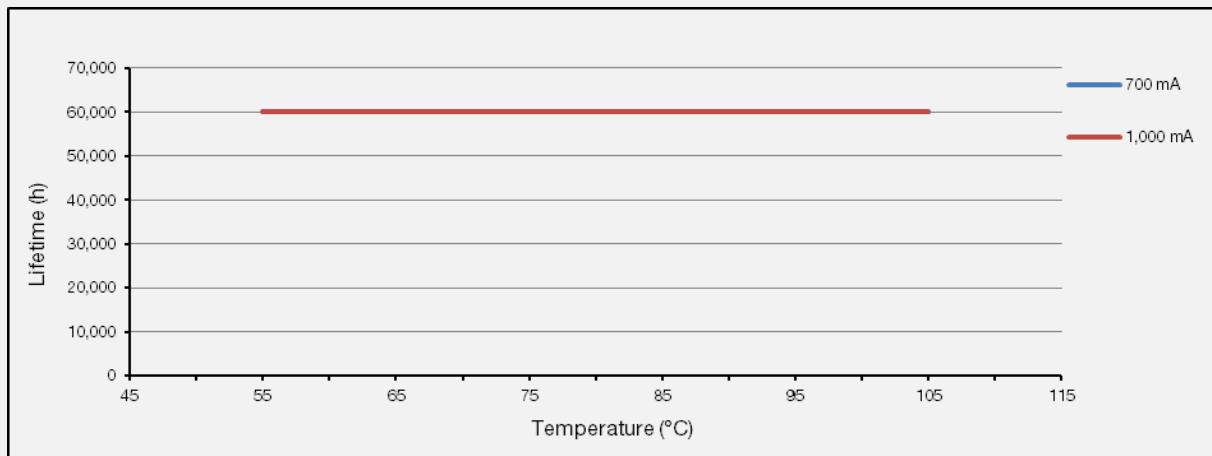
- Report date: 2013.07.24
- Applicable order codes: SPHWHTL3D3\*\*\*\*\*

### Test Summary

- Sample size: 28 pcs
- Number of failures: 0 pcs

Drive Current (mA)	Temperature $T_s$ (°C)	Test Duration (h)	Test Result Lumen Maintenance	Reported IES TM-21-11 Lifetime (h)		
				$L_{70}$	$L_{80}$	$L_{90}$
700	55	10,000	98.7 %	> 60,000	> 60,000	> 60,000
	85		98.5 %	> 60,000	> 60,000	> 60,000
	105		98.2 %	> 60,000	> 60,000	= 48,000
1,000	55	10,000	97.6 %	> 60,000	> 60,000	> 60,000
	85		97.3 %	> 60,000	> 60,000	= 51,000
	105		96.7 %	> 60,000	> 60,000	= 46,000

### $L_{70}$ Temperature Interpolation Graph



# IES LM-80 Test Results

## LH351B

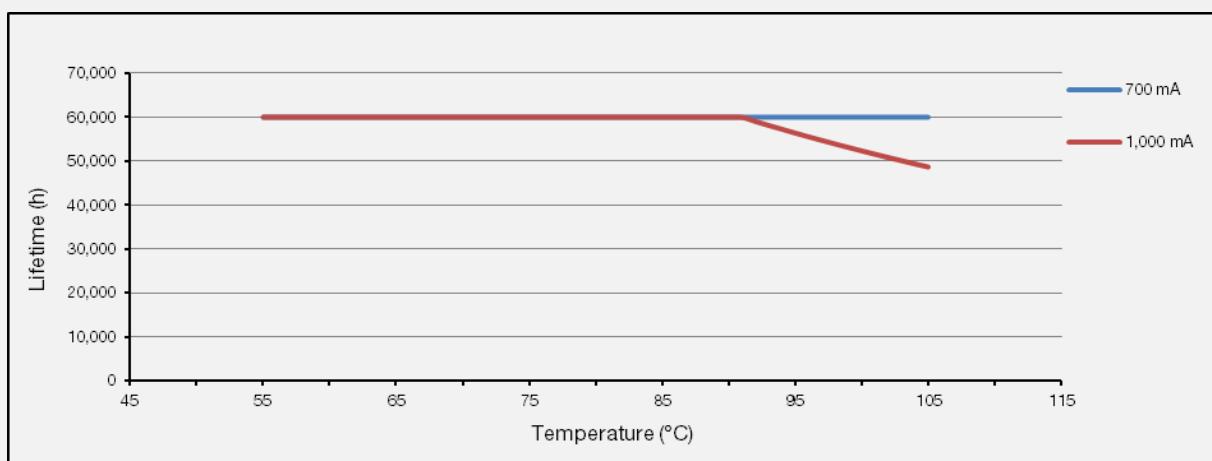
- Report date: 2014.09.30
- Applicable order codes: SPHWH1L3D3\*\*\*\*\*  
SPHWH2L3D3\*\*\*\*\*  
SPHWH3L3D3\*\*\*\*\*

### Test Summary

- Sample size: 25 pcs
- Number of failures: 0 pcs

Drive Current (mA)	Temperature $T_s$ (°C)	Test Duration (h)	Test Result Lumen Maintenance	Reported IES TM-21-11 Lifetime (h)		
				$L_{70}$	$L_{80}$	$L_{90}$
700	55	10,000	99.4 %	> 60,000	> 60,000	= 45,000
	85		96.8 %	> 60,000	> 60,000	= 38,000
	105		94.0 %	> 60,000	= 58,000	= 23,000
1,000	55	10,000	96.2 %	> 60,000	> 60,000	= 36,000
	85		93.5 %	> 60,000	= 40,000	= 18,000
	105		91.8 %	= 51,000	= 31,000	= 13,000

### $L_{70}$ Temperature Interpolation Graph



# IES LM-80 Test Results

## LH351Z

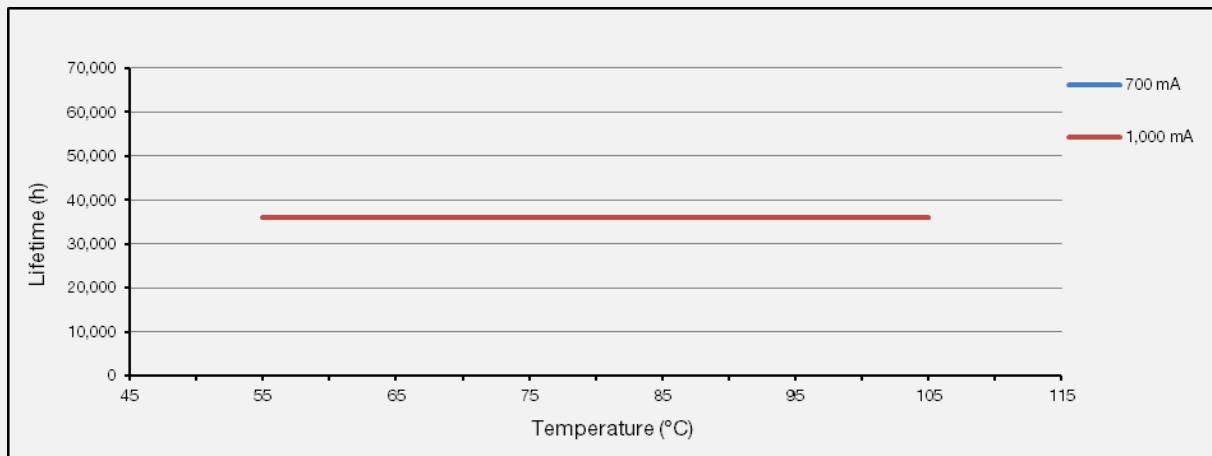
- Report date: 2014.06.17
- Applicable order codes: SPHWHTL3D2\*\*\*\*\*

### Test Summary

- Sample size: 30 pcs (700 mA), 25 pcs (1,000 mA)
- Number of failures: 0 pcs

Drive Current (mA)	Temperature $T_s$ (°C)	Test Duration (h)	Test Result Lumen Maintenance	Reported IES TM-21-11 Lifetime (h)		
				$L_{70}$	$L_{80}$	$L_{90}$
700	55	6,000	99.7 %	> 36,000	> 36,000	> 36,000
	85		98.6 %	> 36,000	> 36,000	> 36,000
	105		97.1 %	> 36,000	> 36,000	= 29,000
1,000	55	6,000	99.3 %	> 36,000	> 36,000	> 36,000
	85		99.4 %	> 36,000	> 36,000	> 36,000
	105		98.6 %	> 36,000	> 36,000	> 36,000

### $L_{70}$ Temperature Interpolation Graph



# IES LM-80 Test Results

## LH351Y

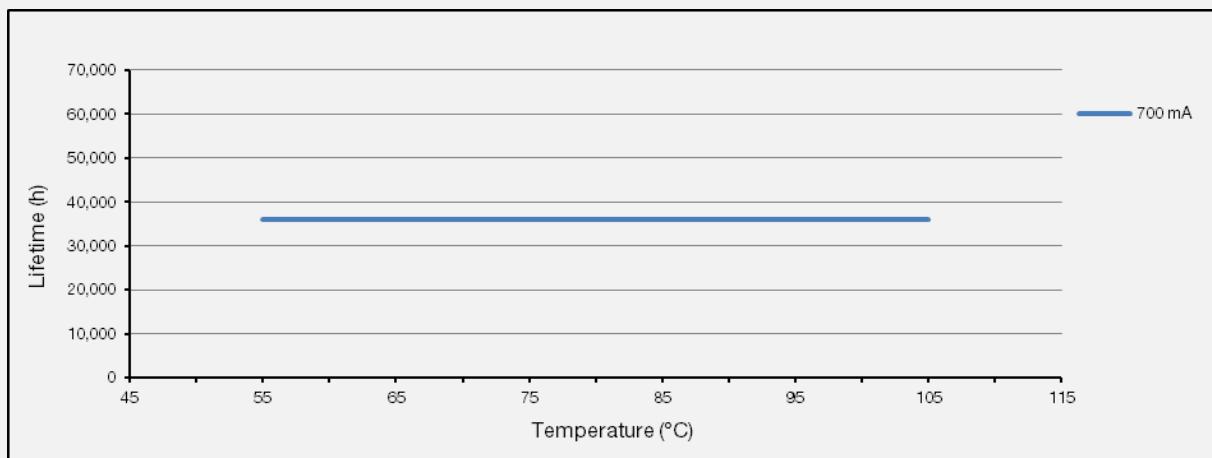
- Report date: 2013.10.31
- Applicable order codes: SPHWHTL3D2\*\*\*\*\*

### Test Summary

- Sample size: 30 pcs
- Number of failures: 0 pcs

Drive Current (mA)	Temperature T <sub>s</sub> (°C)	Test Duration (h)	Test Result Lumen Maintenance	Reported IES TM-21-11 Lifetime (h)		
				L <sub>70</sub>	L <sub>80</sub>	L <sub>90</sub>
700	55	6,000	99.7 %	> 36,000	> 60,000	> 36,000
	85		98.6 %	> 36,000	> 36,000	> 36,000
	105		97.1 %	> 36,000	> 36,000	= 29,000

### L<sub>70</sub> Temperature Interpolation Graph



# IES LM-80 Test Results

## LCxxxB Series

- Report date: 2014.01.20 (@ sorting current); 2014.11.24 (@ sorting current x 1.5)
- Applicable order codes:
 

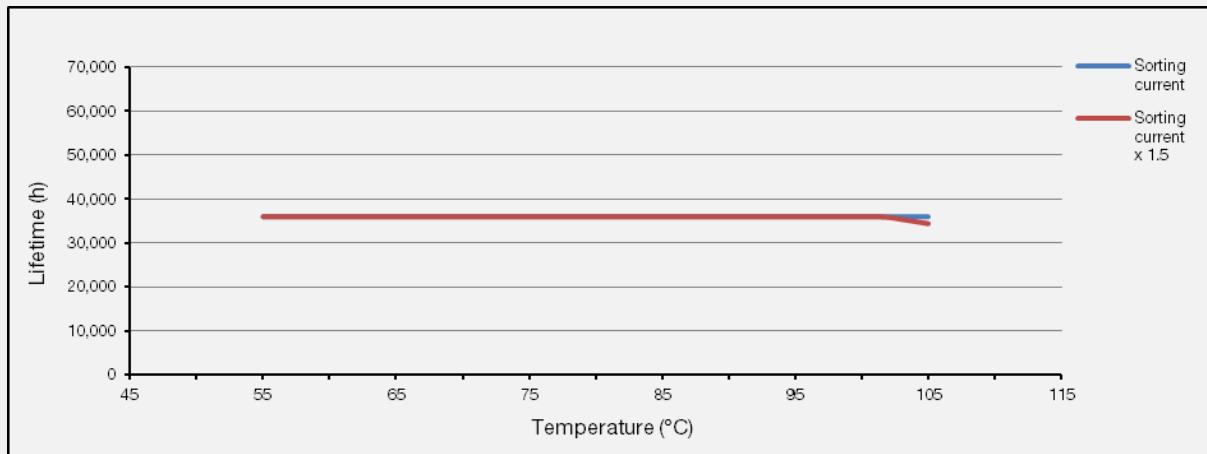
SPH*W1HDNE*****	<b>LC040B</b>	@ 1,080 mA (s.c.)	and 1,620 mA (s.c. x 1.5)
SPH*W1HDND*****	<b>LC033B</b>	900 mA	1,350 mA
SPH*W1HDNC*****	<b>LC026B</b>	720 mA	1,080 mA
SPH*W1HDNB*****	<b>LC019B</b>	540 mA	810 mA
SPH*W1HDNA*****	<b>LC013B</b>	360 mA	540 mA
SPH*W1HDN9*****	<b>LC008B</b>	240 mA	360 mA
SPH*W1HDN8*****	<b>LC006B</b>	180 mA	270 mA

## Test Summary

- Test product: LC040B
- Sample size: 20 pcs
- Number of failures: 0 pcs

Drive Current (mA)	Temperature $T_s$ (°C)	Test Duration (h)	Test Result Lumen Maintenance	Reported IES TM-21-11 Lifetime (h)		
				$L_{70}$	$L_{80}$	$L_{90}$
Sorting Current	55	6,000	100.1 %	> 36,000	> 36,000	> 36,000
	85		98.5 %	> 36,000	> 36,000	= 23,000
	105		96.9 %	> 36,000	= 31,000	= 16,000
Sorting Current x 1.5	55	6,000	97.0%	> 36,000	> 36,000	= 23,000
	105		93.0%	= 34,000	= 21,000	= 9,000

## $L_{70}$ Temperature Interpolation Graph



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Samsung Electronics Co., Ltd.  
95, Samsung 2-ro  
Giheung-gu  
Yongin-si, Gyeonggi-do, 446-711  
KOREA

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